

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application Serial No. 10/734,999
Filing Date December 12, 2003
Inventor Eugene P. Marsh et al.
Assignee Micron Technology, Inc.
Group Art Unit 2822
Examiner Khanh B. Duong
Attorney's Docket No. MI22-2461
Customer No. 021567
Title: Deposition Methods With Time Spaced and Time Abutting Precursor Pulses

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT


References - See Attached Form PTO-1449

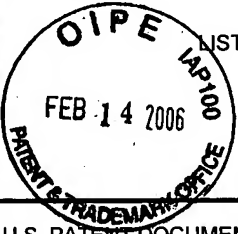
In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

This Supplemental Information Disclosure Statement is being filed before the mailing of a first office action after the filing of a Request for Continued Examination. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925.

Respectfully submitted,

Dated: 2-14-06

By: 
Mark S. Matkin
Reg. No. 32,268

| Form PTO-1449 | | U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE | | ATTY. DOCKET NO. MI22-2461 | | SERIAL NO. 10/734,999 | | |
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|  <p>LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)</p> | | | | APPLICANT: Garo J. Derderian et al. | | | | |
| | | | | FILING DATE December 12, 2003 | | GROUP ART UNIT 2822 | | |
| U.S. PATENT DOCUMENTS | | | | | | | | |
| *Examiner's Initials | | Document Number | Date | Name | Class | Subclass | Filing Date If Appropriate | |
| | AA | 6,821,347 B2 | 11/23/04 | Carpenter | | | | |
| | AB | 2005/0037597 A1 | 02/1705 | Nguyen et al. | | | | |
| | AC | | | | | | | |
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| FOREIGN PATENT DOCUMENTS | | | | | | | | |
| | | Document Number | Date | Country | Class | Subclass | Translation | |
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| | AK | | | | | | | |
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| OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) | | | | | | | | |
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| <p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p> | | | | | | | | |